

## N-Channel 650 V (D-S) MOSFET

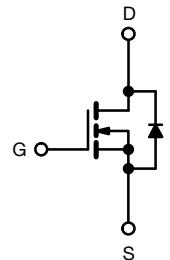
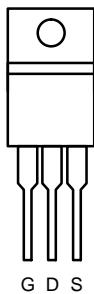
<b>PRODUCT SUMMARY</b>	
$V_{DS}$ (V) at $T_J$ max.	650
$R_{DS(on)}$ max. ( $\Omega$ ) at 25 °C	$V_{GS} = 10$ V    0.34
$Q_g$ max. (nC)	106
$Q_{gs}$ (nC)	14
$Q_{gd}$ (nC)	33
Configuration	Single

### FEATURES

- Reduced  $t_{rr}$ ,  $Q_{rr}$ , and  $I_{RRM}$
- Low figure-of-merit (FOM)  $R_{on} \times Q_g$
- Low input capacitance ( $C_{iss}$ )
- Low switching losses due to reduced  $Q_{rr}$
- Ultra low gate charge ( $Q_g$ )
- Avalanche energy rated (UIS)



TO-220AB



N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_C = 25$ °C, unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage	$V_{GS}$ at 10 V	$V_{DS}$	650	V
Gate-Source Voltage		$V_{GS}$	$\pm 30$	
Continuous Drain Current ( $T_J = 150$ °C)	$T_C = 25$ °C $T_C = 100$ °C	$I_D$	18	A
Pulsed Drain Current <sup>a</sup>		$I_{DM}$	16	
Pulsed Drain Current <sup>a</sup>		$I_{DM}$	53	
Linear Derating Factor			1.7	W/°C
Single Pulse Avalanche Energy <sup>b</sup>		$E_{AS}$	367	mJ
Maximum Power Dissipation		$P_D$	208	W
Operating Junction and Storage Temperature Range		$T_J, T_{stg}$	-55 to +150	°C
Drain-Source Voltage Slope	$T_J = 125$ °C	$dV/dt$	37	V/ns
Reverse Diode $dV/dt$ <sup>d</sup>			31	
Soldering Recommendations (Peak Temperature) <sup>c</sup>	for 10 s		300	°C

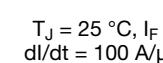
#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature.
- $V_{DD} = 50$  V, starting  $T_J = 25$  °C,  $L = 28.2$  mH,  $R_g = 25$  Ω,  $I_{AS} = 5.1$  A.
- 1.6 mm from case.
- $I_{SD} \leq I_D$ ,  $dl/dt = 100$  A/μs, starting  $T_J = 25$  °C.

**THERMAL RESISTANCE RATINGS**

PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	62	$^{\circ}\text{C}/\text{W}$
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	0.5	

**SPECIFICATIONS** ( $T_J = 25^{\circ}\text{C}$ , unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
<b>Static</b>								
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}$	$I_D = 250 \mu\text{A}$	650	-	-	V	
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to $25^{\circ}\text{C}$ , $I_D = 1 \text{ mA}$		-	0.67	-	$^{\circ}\text{C}/\text{V}$	
Gate-Source Threshold Voltage (N)	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$		2.5	-	4	V	
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 20 \text{ V}$		-	-	$\pm 100$	nA	
		$V_{GS} = \pm 30 \text{ V}$		-	-	$\pm 1$	$\mu\text{A}$	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 650 \text{ V}$ , $V_{GS} = 0 \text{ V}$		-	-	1	$\mu\text{A}$	
		$V_{DS} = 520 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $T_J = 125^{\circ}\text{C}$		-	-	500		
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10 \text{ V}$	$I_D = 11 \text{ A}$	-	0.34	-	$\Omega$	
Forward Transconductance	$g_{fs}$	$V_{DS} = 30 \text{ V}$ , $I_D = 11 \text{ A}$		-	7.0	-	S	
<b>Dynamic</b>								
Input Capacitance	$C_{iss}$	$V_{GS} = 0 \text{ V}$ , $V_{DS} = 100 \text{ V}$ , $f = 1 \text{ MHz}$		-	4826	-	pF	
Output Capacitance	$C_{oss}$			-	456	-		
Reverse Transfer Capacitance	$C_{rss}$			-	210	-		
Effective Output Capacitance, Energy Related <sup>a</sup>	$C_{o(er)}$	$V_{DS} = 0 \text{ V}$ to $520 \text{ V}$ , $V_{GS} = 0 \text{ V}$		-	84	-	pF	
Effective Output Capacitance, Time Related <sup>b</sup>	$C_{o(tr)}$			-	293	-		
Total Gate Charge	$Q_g$			-	71	-	nC	
Gate-Source Charge	$Q_{gs}$	$V_{GS} = 10 \text{ V}$	$I_D = 11 \text{ A}$ , $V_{DS} = 520 \text{ V}$	-	14	-		
Gate-Drain Charge	$Q_{gd}$			-	33	-		
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 520 \text{ V}$ , $I_D = 11 \text{ A}$ , $V_{GS} = 10 \text{ V}$ , $R_g = 9.1 \Omega$		-	22	-	ns	
Rise Time	$t_r$			-	34	-		
Turn-Off Delay Time	$t_{d(off)}$			-	68	-		
Fall Time	$t_f$			-	42	-		
Gate Input Resistance	$R_g$	$f = 1 \text{ MHz}$ , open drain		-	0.78	-	$\Omega$	
<b>Drain-Source Body Diode Characteristics</b>								
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p - n junction diode		-	-	21	A	
Pulsed Diode Forward Current	$I_{SM}$			-	-	53		
Diode Forward Voltage	$V_{SD}$	$T_J = 25^{\circ}\text{C}$ , $I_S = 11 \text{ A}$ , $V_{GS} = 0 \text{ V}$		-	0.9	1.2	V	
Reverse Recovery Time	$t_{rr}$	$T_J = 25^{\circ}\text{C}$ , $I_F = I_S = 11 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ , $V_R = 25 \text{ V}$		-	160	-	ns	
Reverse Recovery Charge	$Q_{rr}$			-	1.2	-	$\mu\text{C}$	
Reverse Recovery Current	$I_{RRM}$			-	14	-	A	

**Notes**

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .  
b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .

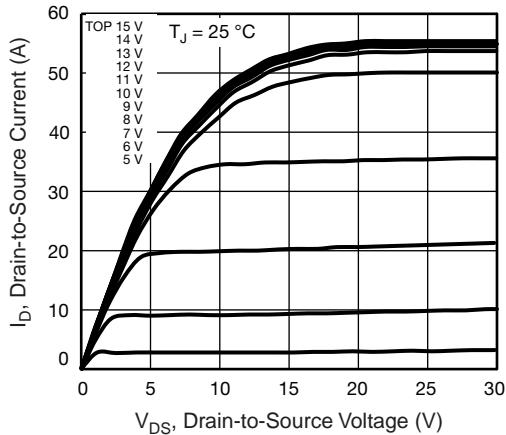
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

Fig. 1 - Typical Output Characteristics

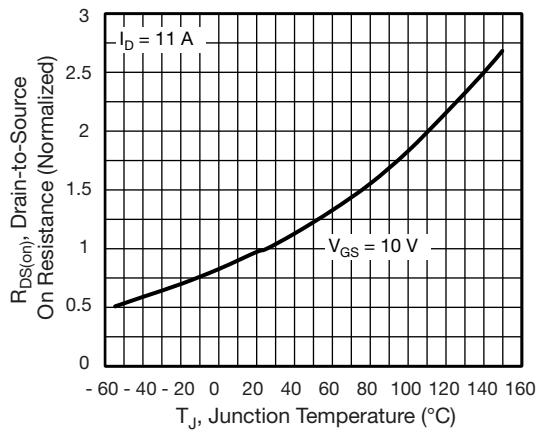


Fig. 4 - Normalized On-Resistance vs. Temperature

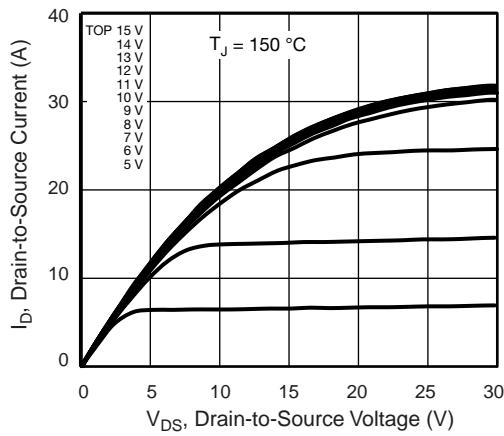


Fig. 2 - Typical Output Characteristics

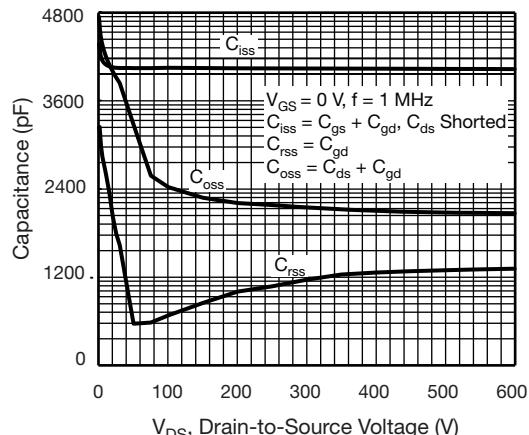


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

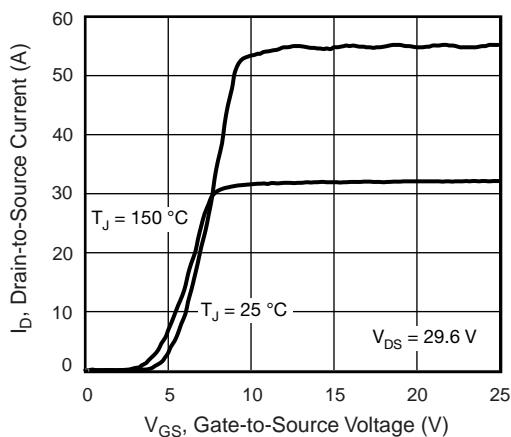
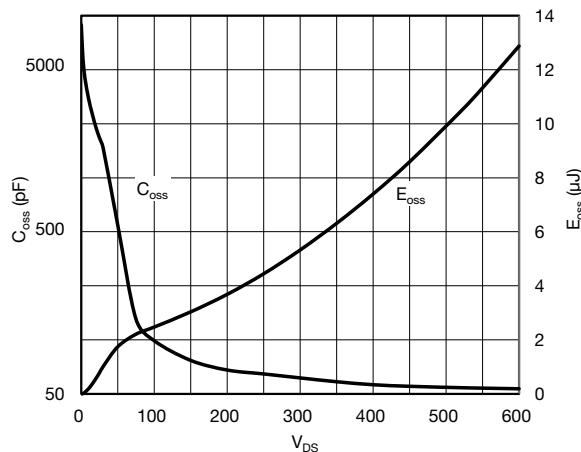


Fig. 3 - Typical Transfer Characteristics

Fig. 6 -  $C_{oss}$  and  $E_{oss}$  vs.  $V_{DS}$

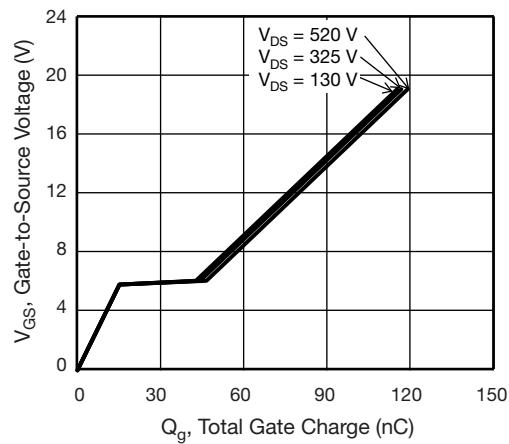


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

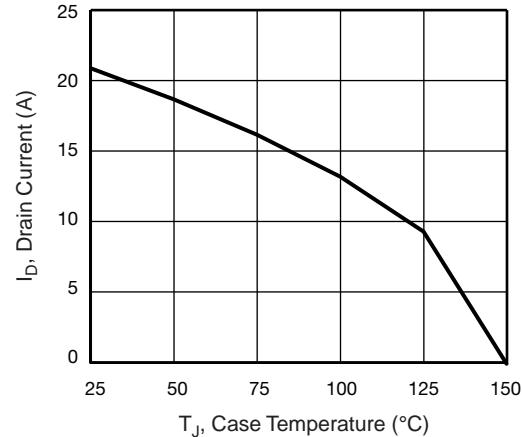


Fig. 10 - Maximum Drain Current vs. Case Temperature

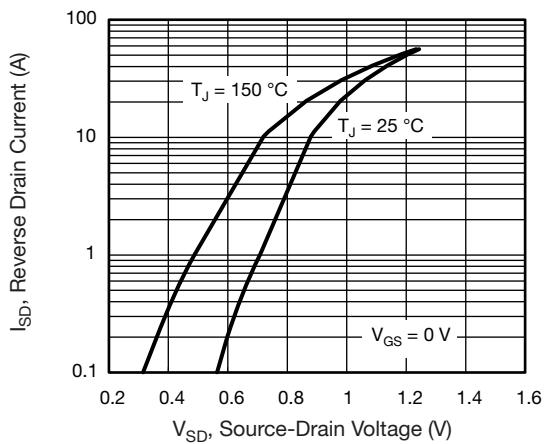


Fig. 8 - Typical Source-Drain Diode Forward Voltage

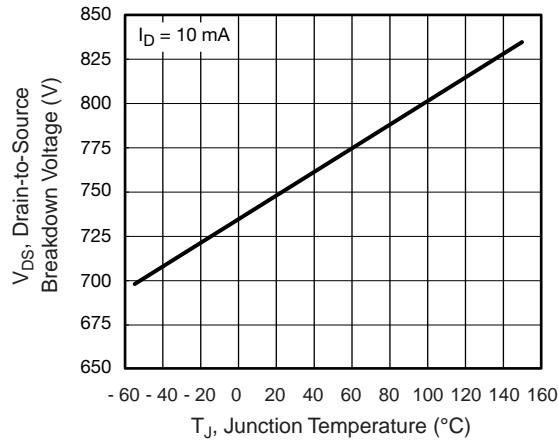


Fig. 11 - Temperature vs. Drain-to-Source Voltage

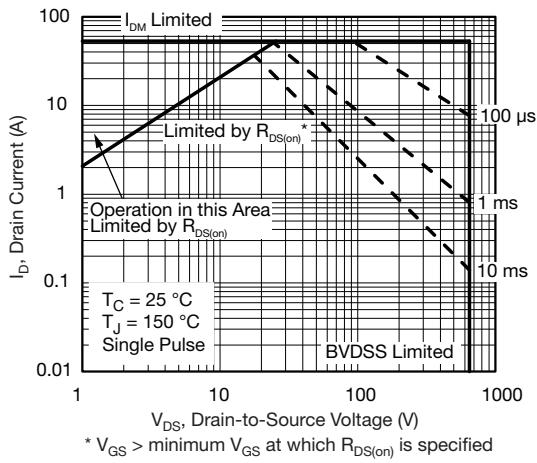


Fig. 9 - Maximum Safe Operating Area

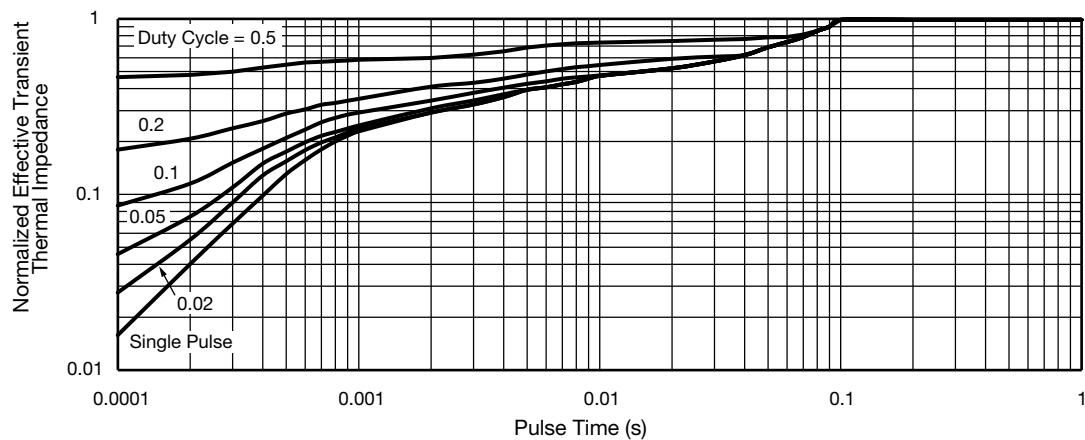


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

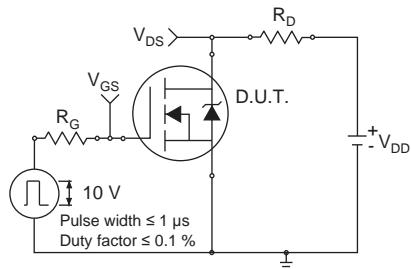


Fig. 13 - Switching Time Test Circuit

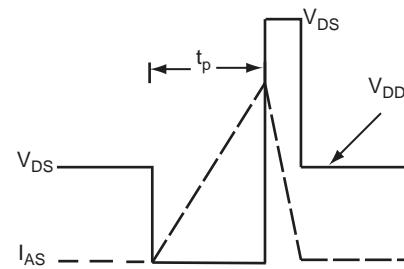


Fig. 16 - Unclamped Inductive Waveforms

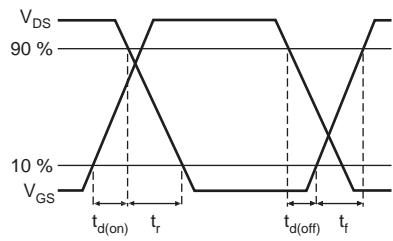


Fig. 14 - Switching Time Waveforms

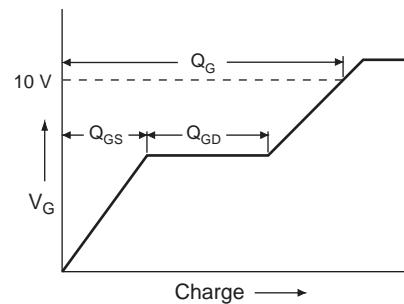


Fig. 17 - Basic Gate Charge Waveform

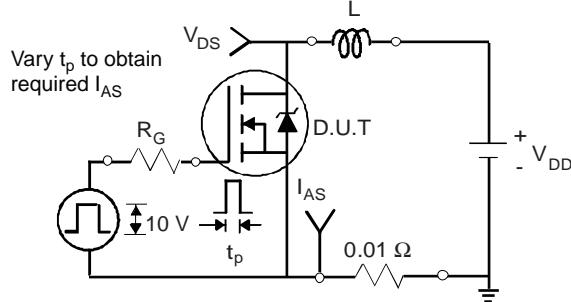


Fig. 15 - Unclamped Inductive Test Circuit

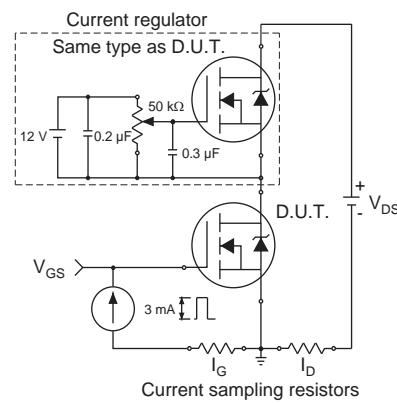
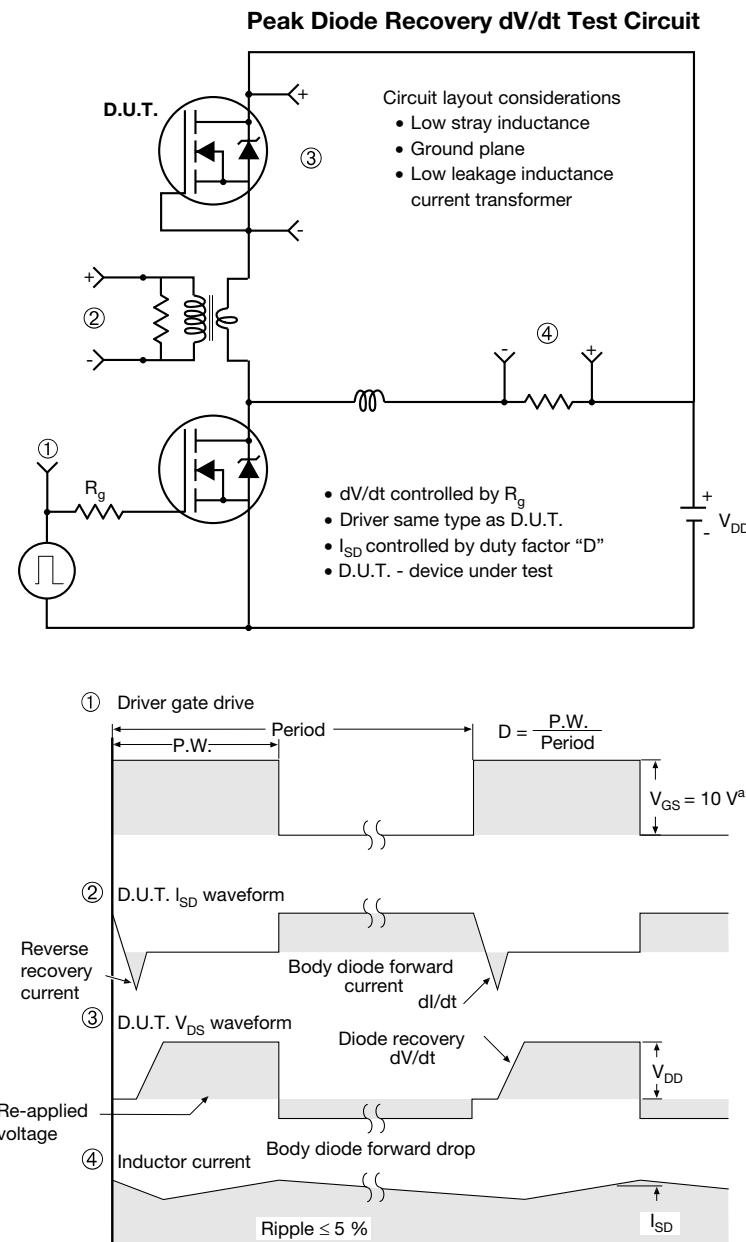
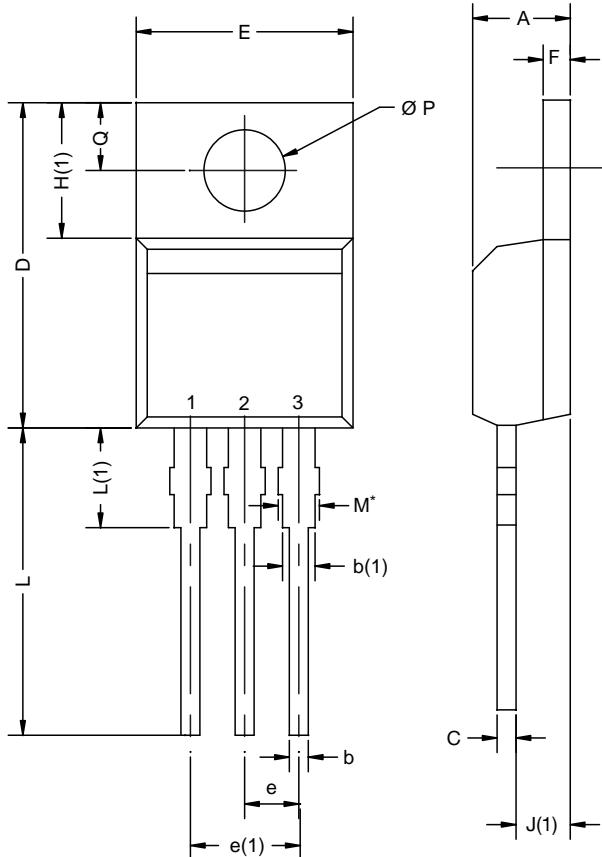


Fig. 18 - Gate Charge Test Circuit

**Fig. 19 - For N-Channel**

## TO-220AB



DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
c	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
E	10.04	10.51	0.395	0.414
e	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
Ø P	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118

ECN: X12-0208-Rev. N, 08-Oct-12  
 DWG: 5471

**Notes**

\* M = 1.32 mm to 1.62 mm (dimension including protrusion)  
 Heatsink hole for HVM

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